



# 6th SRF Materials Workshop

## Friday, 19 February 2010

### Session 6: Q(E) and Rs measurements (10:10 - 11:20)

time	[id] title	presenter
10:10	[74] TE Cavity work	, Liepe (Cornell)
10:20	[75] Current Status of Dielectric Test Cavity and Wafer Test Cavity	, Pogue (TAMU)
10:30	[76] RF Critical Magnetic Field Measurements of Nb/(Insulator)/MgB2 Systems	, Tajima (LANL)
10:40	[77] Local measurements of the electron mean free path	, Phillips (JLab)
10:50	[78] Progress in near-field microwave microscopy of superconducting materials	, Anlage (Maryland)
11:00	[79] Discussion	